

IDS Form PTO/SB/08: Substitute for form 1449A/PTO				<i>Complete if Known</i>													
INFORMATION DISCLOSURE STATEMENT BY APPLICANT <i>(Use as many sheets as necessary)</i>				<table border="1" style="width: 100%; border-collapse: collapse;"> <tr> <td>Application Number</td> <td>10/814,430</td> </tr> <tr> <td>Filing Date</td> <td>April 1, 2004</td> </tr> <tr> <td>First Named Inventor</td> <td>Gregory PLOS et al.</td> </tr> <tr> <td>Art Unit</td> <td>1751</td> </tr> <tr> <td>Examiner Name</td> <td>E. Elhilo</td> </tr> <tr> <td>Attorney Docket Number</td> <td>05725.1308-00000</td> </tr> </table>		Application Number	10/814,430	Filing Date	April 1, 2004	First Named Inventor	Gregory PLOS et al.	Art Unit	1751	Examiner Name	E. Elhilo	Attorney Docket Number	05725.1308-00000
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U.S. PATENTS AND PUBLISHED U.S. PATENT APPLICATIONS					
Examiner Initials	Cite No.	Document Number	Issue or Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number-Kind Code (<i>if known</i>)			
EE	1	US 4,517,174	5/14/1985	Jacquet et al.	
	2	US 5,057,311	10/15/1991	Kamegai et al.	
	3	US 5,275,808	1/14/1994	De Groot et al.; Murray et al.	
	4	US 5,316,551	5/31/1994	Wenke	
	5	US 5,733,343	3/31/1998	Mockli	
	6	US 6,001,135	12/14/1999	Rondeau et al.	
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	9	US 6,570,019	5/27/2003	Pasquier et al.	
	10	US 6,576,024	6/10/2003	Lang et al.	
	11	US 2001/0023514	9/27/2001	Cottard et al.	
	12	US 2002/0046431	4/25/2002	Laurent et al.	
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EE	16	US 2005/0008593	1/13/2005	Plos et al.	

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Examiner Initials	Cite No.	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	Translation
		Country Code Number Kind Code (<i>if known</i>)				
EE	17	EP 1 142 559	4/1/2001	Miyabe et al.		
	18	FR 2 773 470	7/16/1999	Malnou et al.		Abstract
	19	JP 2001-302473	10/31/2001	Hiroichi		Abstract
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EE	22	JP 2004-307494	11/4/2004	Plos et al.		English Counterpart

Examiner Signature	/Eisa Elhilo/	Date Considered	10/19/2006
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EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.